

Scientific Program

4th International Workshop on Ultraviolet Materials and Devices (IWUMD4)

September 9-13, 2019, Saint-Petersburg, Russia

Monday, September 9

<i>Registration</i>	17:00 - 19:00
<i>Welcome reception</i>	19:00 - 22:00

Tuesday, September 10

<i>Registration</i>	8:00 - 18:00
Welcome greetings	8:45 - 9:00
Plenary and Keynotes Session	9:00 - 10:45

Session Chair: Bernard Gil

Tu-1P	9:00 - 9:45	
	Boron Nitride and Boron-Containing Nitride Alloys (<i>plenary</i>)	
	<u>Chris G. Van de Walle</u>	
	<i>University of California, Santa Barbara, USA</i>	
Tu-1K	9:45 - 10:15	
	Deep-UV Optical Properties of Ultrathin GaN/AlN Quantum Wells (<i>keynote</i>)	
	<u>Alexey Toropov</u>	
	<i>Ioffe Institute, Russia</i>	
Tu-2K	10:15 – 10:45	
	Problems and Latest Achievements in AlGaN-Based Deep-UV LEDs (<i>keynote</i>)	
	<u>Hideki Hirayama</u>	
	<i>RIKEN, Japan</i>	
	<i>Coffee Break</i>	10:45 - 11:15

Session 1 “Oxides Growth and Fundamental Properties”

11:15 - 12:40

Tu-1i

Session Chair: Tatiana Shubina

11:15 - 11:35

Thermal Conductivity, Elasticity, Phonon Modes, and Optical Band Gap of Gallium Oxide Polymorphs (*invited*)

Markus R. Wagner, H. Tornatzky, S. Kalinowski, S.T. Jagsch, N. Jankowski, L. Grote, T. Kure, F. Nippert, A. Hoffmann, R. Gillen, B. Graczykowski, J.S. Reparaz

Technical University of Berlin, Germany & Friedrich-Alexander-Universität Erlangen-Nürnberg, Germany & Max Planck Institute for Polymer Research, Germany & ICMAB-CSIC, Spain

Tu-2i

11:35 - 11:55

Observation of Deep-UV Cathodoluminescence from Rocksalt-Structured MgZnO Alloys (*invited*)

Takeyoshi Onuma, M. Ono, K. Kudo, K. Ishii, K. Kaneko, S. Fujita, and T. Honda

Kogakuin University & Kyoto University, Japan

Tu-1o

11:55 – 12:10

 α -Ga₂O₃: a Novel WBG Semiconductor for UV Optoelectronics and Power Electronic Devices

V.I. Nikolaev, A.I. Pechnikov, S.I. Stepanov, A.Y. Polyakov

Perfect Crystals LLC, Russia & Ioffe Institute, Russia & National University of Science and Technology MISiS, Russia

Tu-2o

12:10 – 12:25

Effects of Different Plasma Treatments on Deep Traps Spectra and Leakage Current of Ga₂O₃ Crystals and Films

A.Y. Polyakov, I.-H. Lee, N.B. Smirnov, E.B. Yakimov,

I.V. Shchemerov, A.V. Chernykh, A.I. Kochkova, A.A. Vasilev, F. Ren, P. Carey, S.J. Pearton

National University of Science and Technology MISiS, Russia & Institute of Microelectronics Technology and High Purity Materials, Russia & Seoul University, Korea & University of Florida, USA

Tu-3o

12:25 – 12:40

HVPE Growth and Characterisation of α -, β -, ϵ -Ga₂O₃ Epitaxial Films

S.I. Stepanov, V.I. Nikolaev, A.I. Pechnikov, O.S. Medvedev, M.P. Sheglov, A.V. Chikiryaka, S.V. Shapenkov, E.V. Ubyivovk, O.F. Vyvenko

Perfect Crystals LLC & Ioffe Institute, Russia & St. Petersburg State University, Russia

	Lunch	12:40 - 14:00
Session 2	"AlGaN Bulk Substrates and Templates"	14:00 - 15:45
	Session Chair: Hiroshi Fujioka	
Tu-3i	14:00 – 14:20 Preparation of High-Quality AlN Templates for Deep UV Devices (invited) <u>Hideto Miyake</u> , K. Shojiki, K. Uesugi, S. Xiao, H. Koizumi, and S. Kuboya <i>Mie University, Japan</i>	
Tu-4i	14:20 – 14:40 Al(Ga)N/Sapphire Template Technologies for Deep UV LEDs (invited) <u>Markus Weyers</u> , S. Hagedorn, A. Knauer, S. Walde <i>Ferdinand-Braun-Institut, Leibniz-Institut fuer Hoechstfrequenztechnik, Germany</i>	
Tu-5i	14:40 – 15:00 AlN Growth Behavior on Ni-Al Liquid Solution (invited) <u>Masayoshi Adachi</u> , S. Sonoko, A. Kanbara, L.G. Wilson, B.G. Pierce, A.M. Karimi, R.H. French, J.L.W. Carter, and H. Fukuyama <i>Tohoku University, Japan & Case Western Reserve University, USA</i>	
Tu-4o	15:00 – 15:15 2-Inch AlN Substrates for UV Devices <u>R. Dalmau</u> , J. Britt, R. Schlesser <i>HexaTech, Inc., USA</i>	
Tu-5o	15:15 – 15:30 High Quality AlN Growth by Ammonia-Free High Temperature MOVPE <u>X.Q. Shen</u> , K. Kojima, and H. Okumura <i>National Institute of Advanced Industrial Science and Technology (AIST), Japan</i>	
Tu-6o	15.30 - 15.45 Vertically Oriented Graphene Nanowall Assisted-Growth of AlN Film and Its Heat Dissipation for Ultraviolet Light-Emitting Diodes <u>T. Wei</u> , H. Ci, H. Chang, J. Yan, P. Gao, J. Wang, J. Li, and Zh. Liu <i>Institute of Semiconductors, CAS, China & College of Chemistry and Molecular Engineering, Peking University, China</i>	

Coffee Break 15:45 - 16:15

Session 3 “UV Lasers and E-beam Emitters” 16:15 - 17:40
Session Chair: Alex Toropov

Tu-6i 16:15 – 16:35

High Current Density Operation of UV-B Light-Emitting Devices Fabricated on High Quality and Relaxed AlGaN (*invited*)

Motoaki Iwaya, S. Yasue, K. Sato, Y. Sakuragi, Y. Ogino, S. Tanaka, S. Teramura, S. Iwayama, T. Takeuchi, S. Kamiyama, I. Akasaki, and H. Miyake

Meijo University, Japan & Asahi-Kasei Corporation, Japan & Mie University, Japan & Akasaki Research Center, Nagoya University, Japan

Tu-7i 16:35 – 16:55

E-beam Pumped Deep UV Light Source Based on Ultrathin GaN QWs (*invited*)

Xinqiang Wang, Y.X. Wang, S.V. Ivanov, T. Wang, B. Sheng, S. Guo, H. Miyake, V.I. Kozlovsky, F. Bertram, H. Li, X. Rong, Z.X. Qin, J. Christen, and B. Shen

Peking University, China & Ioffe Institute, Russia & Advanced Micro-Fabrication Equipment Inc., China & Mie University, Japan & Lebedev Physical Institute, Russia Otto-von-Guericke-University Magdeburg, Germany

Tu-7o 16:55 – 17:10

Light Confinement and Vertical Conduction over 40 kA/cm² with p-AlGaN Composition-Graded Cladding Layer of UVB Laser Diode Structure

K. Sato, Sh. Yasue, Y. Ogino, Sh. Tanaka, M. Iwaya, T. Takeuchi, S. Kamiyama, and I. Akasaki

Asahi-Kasei Corporation, Japan & Meijo University, Japan & Akasaki Research Center, Nagoya University, Japan

Tu-8o 17:10 - 17:25

Watt-Range E-Beam Pumped 245 nm-Emitter Based on GaN/AlN MQW Structures Grown by PA MBE on Sapphire

N.A. Gamov, V.N. Jmerik, D.V. Nechaev, O.A. Koshelev, V.I. Kozlovsky, V.P. Martovitsky, D.E. Sviridov, Y.K. Skasyrsky, E.V. Zhdanova, M.M. Zverev, and S.V. Ivanov

MIREA – Russian Technological University, Russia & Ioffe Institute, Russia & P.N. Lebedev Physical Institute, Russia

Tu-9o	17:25 – 17:40	Engineering of Material Gain for Staggered Polar AlGaN/AlN Quantum Wells Dedicated for Deep UV Lasers <u>M. Gladysiewicz</u> , D. Hommel, R. Kudrawiec <i>Wroclaw University of Science and Technology, Poland</i>
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Poster session I 18:00 - 19:30

Wednesday, September 11

Registration	8:00 - 18:00
Session 4 “UV LEDs & Photodetectors I”	9:00 - 10:40
Session Chair: Hideki Hirayama	
We-1i	9:00 - 9:20
Improving the Reliability of UV LEDs by Analyzing Degradation Mechanisms (<i>invited</i>)	
<u>Sven Einfeldt</u> , J. Glaab, J. Ruschel, J. Rass, H.-K. Cho, N. Lobo Ploch, T. Kolbe, A. Knauer, S. Hagedorn, C. Stölmacker, K. Hilbrich, N. Susilo, L. Sulmoni, M. Guttmann, T. Wernicke, M. Weyers, M. Kneissl <i>Ferdinand-Braun-Institut, Germany & Technische Universität Berlin, Germany</i>	
We-2i	9:20 - 9:40
Achieving Ultralow Resistance p-Contacts in Deep-UV LEDs (<i>invited</i>)	
<u>Debdeep Jena</u> <i>Cornell University, USA</i>	
We-1o	9:40 - 9:55
Greatly Enhanced Performance of AlGaN-Based Deep Ultraviolet Light Emitting Diodes by Introducing a Polarization Modulated Electron Blocking Layer	
<u>J. Lang</u> , F. Xu, W. Ge, Y. Sun, N. Zhang, and B. Shen <i>State Key Laboratory of Artificial Microstructure and Mesoscopic Physics, School of Physics, Peking University, China</i>	

We-2o	9:55 – 10:10	Degradation Effects in AlGaN-Based Deep-Ultraviolet Light-Emitting Diodes Emitting near 233 nm <u>J. Glaab</u> , J. Ruschel, H. K. Cho, M. Lapeyrade, J. Rass, F. Mehnke, L. Sulmoni, M. Guttmann, T. Wernicke, M. Weyers, S. Einfeldt, M. Kneissl <i>Ferdinand-Braun-Institut, Germany & Leibniz-Institut für Höchstfrequenztechnik, Germany</i>	
We-3o	10:10 – 10:25	Van der Waals Epitaxy of Nitrides Material and Deep-UV Light-Emitting Diodes <u>Zhiqiang Liu</u> , T. Wei, J. Yan, Y. Wang, Zh. Chen, X. Yi, J. Wang, P. Gao, J. Li, and Zh. Liu <i>State Key Laboratory of Solid-State Lighting, Institute of Semiconductors, CAS, China & College of Chemistry and Molecular Engineering, Peking University, China</i>	
We-4o	10:25 – 10:40	Solar-Blind UV-Photocathodes with Polarized p-Doped AlGaN:Mg/AlN Heterostructures Grown by Plasma-Assisted MBE <u>P.S. Alkov</u> , <u>L.M. Balyasnii</u> , Yu.K.Gruzevich, O.V. Chistov, V.N. Jmerik, D.V. Nechaev, and S.V. Ivanov <i>JSC Science Production Unity "GEOFIZIKA-NV", Russia & Ioffe Institute, Russia</i>	
<i>Coffee Break</i>		10:40 - 11:15	
Session 5 “Optical properties of BN”		11:15 - 12:40	
Session Chair: Guillaume Cassabois			
We-3i	11:15 – 11:35	Pressure Dependence of the Electronic and Polar Phonon Contributions to the Dielectric Function of Hexagonal Boron Nitride (<i>invited</i>) <u>Alfredo Segura</u> , R. Cuscó, T. Taniguchi, K. Watanabe, G. Cassabois, B. Gil, and L. Artús <i>Universitat de València, Spain & ICTJA-CSIC, Spain & National Institute for Materials, Japan & UMR 5221 CNRS-Université de Montpellier, France</i>	

We-4i	11:35 – 11:55	Excitons in van der Waals Heterostructures: from Monolayer to Bulk Hexagonal Boron Nitride (<i>invited</i>) <u>Giorgia Fugallo</u> <i>CNRS /LTEN University of Nantes, France</i>
We-5o	11:55 – 12:10	BAIN and BGaN for Lattice-Matched UV Optical Structures <u>F. AlQatari</u> , M. Sajjad, R. Lin, K.-H. Li, U. Schwingenschlög, X. Li <i>Advanced Semiconductor Laboratory, KAUST, Saudi Arabia</i>
We-6o	12:10 – 12:25	Plasmonic Enhancement in h-BN Based UV Photodetectors B. Mo, J. Yin, J. Li, D. Cai, <u>Jing Li</u> , and J. Kang <i>Xiamen University, China</i>
We-7o	12:25 – 12:40	Reflectivity of Hexagonal Boron-Nitride in Deep UV <u>Ch. Elias</u> , P. Valvin, T. Pelini, A. Summerfield, C.J. Mellor, T.S. Cheng, L. Eaves, C.T. Foxon, P.H. Beton, S.V. Novikov, B. Gil, G. Cassabois <i>Laboratoire Charles Coulomb, UMR5221 CNRS-Université de Montpellier, France & University of Nottingham, UK</i>
<i>Lunch</i>		12:40 - 14:00
Session 6 “BN Growth and Properties” & Post deadline		14:00 - 15:45
Session Chair: Xinqiang Wang		
We-5i	14:00 - 14:20	High-Temperature MBE of Hexagonal Boron Nitride for DUV Applications (<i>invited</i>) T.S. Cheng, A. Summerfield, C.J. Mellor, C. Elias, P. Valvin, T. Pelini, B. Gil, G. Cassabois, L. Eaves, C.T. Foxon, P.H. Beton, and <u>Sergei Novikov</u> <i>University of Nottingham, UK & UMR5221 CNRS-Université de Montpellier, France</i>
We-6i	14:20 - 14:40	Observation of Impurity Incorporated Regions in Hexagonal Boron Nitride Single Crystals (<i>invited</i>) <u>Kenji Watanabe</u> and Takashi Taniguchi <i>National institute for Materials Science, Japan</i>

We-7i	14:40 – 15:00	Wafer-Scale and Selective-Area Growth of High-Quality h-BN by MOVPE (<i>invited</i>) H. Jeong, D.Y. Kim, J. Kim, S. Moon, and <u>Jong Kyu Kim</u> <i>POSTECH, Republic of Korea</i>
We-8o	15:00 – 15:15	Exceed 20% Boron of Single-Phase Wurtzite in BAIN Film Grown Using MOCVD <u>T.B. Tran</u> , H.-L. Che, F. AlQatari, and X. Li <i>King Abdullah University of Science and Technology (KAUST), Saudi Arabia</i>
We-9o	15:15 – 15:30	Resistance Switching Behavior of B(Al)N Film Fabricated by Sputtering <u>Q. Li</u> , X. Qin, and F. Yun <i>Xi'an Jiaotong University, China</i>
We-10o	15:30 – 15:45	Post deadline paper Performance Enhancement of Deep Ultraviolet AlGaN Based Nanostructures <u>K. Huang</u> , S. Ge, J. Dai, N. Gao, S. Lu, P. Li, B. Liu, J. Kang, R. Zhang & Y. Zheng <i>Xiamen University, China</i>
Coffee Break		15:45 - 16:15
Session 7 “Oxides-Based UV Photonic Devices” Session Chair: Markus Wagner		16:15 - 17:35
We-8i	16:15 – 16:35	Solar-Blind UV Detectors Based on Ga₂O₃ Films (<i>invited</i>) <u>Vera Kalygina</u> <i>Tomsk State University, Russia</i>
We-11o	16:35 – 16:50	Enhanced DUV Solar-Blind Self-Powered Photodetector Based on Novel ZnO Quantum Dot/ CuO Micro-Pyramid p–n Junction” <u>N. Alwadai</u> , S. Mitra, M. N. Hedhili, H. Alamoudi, B. Xin, and I.S. Roqan <i>KAUST, Saudi Arabia & Princess Nourah bint Abdulrahman University, Saudi Arabia</i>

We-12o	16:50 – 17:05	Fabrication of Planar ZnO Microcavities for Near Ultraviolet Polariton Laser Operating at Room Temperature <u>K. Shima</u> , K. Furusawa, K. Kojima, and S.F. Chichibu <i>Tohoku University, Japan</i>
We-13o	17:05 - 17:20	Solution Processed Self-Powered Solar-Blind Photodetector by Amorphous Core-Shell Gallium Oxide Nanoparticles <u>S. Mitra</u> , D.R. Almalawi, Y. Pak, N. Wehbe, I.S. Roqan <i>KAUST, Saudi Arabia</i>
We-14o	17:20 – 17:35	Effects of Annealing Process on Electrical Conductivity of MgZnO <u>M. Kushimoto</u> , T. Sakai, M. Deki, Y. Honda, and H. Amano <i>Nagoya University, Japan</i>

Poster session II 18:00 - 19:30

Thursday, September 12

Registration	8:00 - 12:00
Session 8 “AlGaN Growth, Defects and Doping”	9:00 - 10:45
Session Chair: Valentin Jmerik	
Th-1i	9:00 - 9:20
Surface Rehybridization Effects of B Incorporation at GaN and AlN Surfaces: a Potential Route to Overcome Bulk Solubility Limits (<i>invited</i>)	
<u>Liverios Lymperakis</u> <i>Max-Planck-Institut für Eisenforschung GmbH, Germany</i>	
Th-2i	9:20 - 9:40
In/Mg Codoping of p-type AlN Nanowires for UV-C LEDs Realization (<i>invited</i>)	
A.-M. Siladie, G. Jacopin, A. Cros, N. Garro, E. Robin, D. Calliste, P. Pochet, F. Donatini, J. Pernot, and <u>Bruno Daudin</u> <i>Université Grenoble Alpes, France & CEA, Grenoble, France & Institut Néel, CNRS, France & Universidad de Valencia, Spain</i>	

Th-3i	9:40 - 10:00	Role of Al-Vacancy Complexes in AlN and High AlN Mole Fraction AlGaN Alloys (<i>invited</i>) <u>Shigefusa Chichibu</u> , H. Miyake, and A.Uedono <i>Tohoku University, Japan & Mie University, Japan & University of Tsukuba, Japan</i>
Th-1o	10:00 - 10:15	Study of Dislocations in Homo- and Hetero-Epitaxially Grown AlN Layer <u>K. Goto</u> , Y. Shimizu, T. Nagashima, R. Yamamoto, N. Takekawa, G. Pozina, R. Dalmau, R. Schlessler, R. Collazo, B. Monemar, Z. Sitar, and Y. Kumagai <i>Tokyo University of Agriculture and Technology, Japan & Tokuyama Corporation, Japan & Linköping University, Sweden & HexaTech, Inc. & North Carolina State, USA</i>
Th-2o	10:15 - 10:30	High-Temperature Ammonia MBE - Real Way to Improve Crystal Quality of AlGaN Based Device Heterostructures <u>S.I. Petrov</u> , A.N. Alexeev, V.V. Mamaev, S.A. Novikov, E.V. Lutsenko, M.V. Rzheutski <i>SemiTEq JSC, Russia & Stepanov Institute of Physics, NASB, Belarus</i>
Th-3o	10:30 – 10:45	Structural Recovery of Si-Ion-Implantation Damage of AlN Surfaces by High Temperature Heat Treatment <u>Y. Kumagai</u> , Y. Shimizu, D. Saito, T. Nagashima, R. Yamamoto, N. Takekawa, K. Goto, and B. Monemar <i>Tokyo University of Agriculture and Technology, Japan & Tokuyama Corporation, Japan & Linköping University, Sweden</i>
Coffee Break		10:45 - 11:15
Session 9 “UV LEDs and Photodetectors II”		11:15 - 12:40
Session Chair: Michael Kneissl		
Th-4i	11:15 – 11:35	Detailed Mechanism of High Performance DUV-LEDs Fabricated on the AlN Underlayer with Dense Macrosteps (<i>invited</i>) Yosuke Nagasawa and <u>Akira Hirano</u> <i>UV Craftory Co., Japan</i>

Th-5i	11:35 - 11:55	Research and Development of UV LEDs in China (<i>invited</i>) <u>Junxi Wang</u> , J. Yan, H. Chen, J. Li <i>Insitute of Semiconductors, CAS, China & University of Chinese Academy of Sciences, China</i>
Th-4o	11:55 - 12:10	UVB LEDs Using (Al,Ga)N Quantum Dots and Tunnel Junctions <u>J. Brault</u> , S. Matta, M. Al Khalfiou, T.-H. Ngo, P. Valvin, M. Leroux, B. Damilano, S. Chenot, J. Y. Duboz, J. Massies, C. Chaix, S. Juillaguet, S. Contreras, B. Gil <i>CNRS-CRHEA, France & University of Montpellier, France & RIBER SA, France</i>
Th-5o	12:10 - 12:25	MBE Grown p-Type AlGaN and Deep Ultraviolet Light Emitting Diodes <u>K. Wang</u> , N. Maeda, M.A. Khan, Zh. Li, Y. Wu, T. Tao, B. Liu, R. Zhang, H. Hirayama <i>Nanjing University, China & RIKEN, Japan</i>
Th-6o	12:25 – 12:40	Performance Modulation for Back-Illuminated AlGaN Ultraviolet Avalanche Photodiodes Based on Multiplication Scaling <u>Q. Cai</u> , D. Chen, H. Lu, R. Zhang, and Y. Zheng <i>Nanjing University, China</i>
<i>Lunch</i>		12:40 - 14:00
<i>Social Program</i>		14:00 - 19:00
<i>Workshop Dinner</i>		19:30 - 23:00

Friday, September 13

Session 10 “Optical Properties of III-Nitride Nanostructures” 9:00 - 10:45

Session Chair: Shigefusa Chichibu

Fr-1i 9:00 - 9:20

Carrier Recombination in AlGaN Quantum Wells (*invited*)

F. Nippert, C. Frankerl, M.T. Mazraehno, M.J. Davies,
M.P. Hoffmann, N. Susilo, T. Wernicke, H.-J. Lugauer, T. Kure,
M. Kneissl, M.R. Wagner, and Axel Hoffmann

Technical University of Berlin, Germany & OSRAM Opto Semiconductors GmbH, Germany

Fr-2i 9:20 - 9:40

Quantum Optical Application of Nitride Semiconductor: DUV Laser and Quantum Computer (*invited*)

Ryuji Katayama, M. Uemukai, and T. Tanikawa
Osaka University, Japan

Fr-3i 9:40 - 10:00

Advanced Nanoscale Characterization of AlGaN Quantum Structures Using Liquid-He-Temperature TEM Cathodoluminescence (*invited*)

Juergen Christen
Magdeburg University, Germany

Fr-1o 10:00 – 10:15

Purcell Effect and Strong Coupling in GaN Planar Hexagonal Microcavities

G. Pozina, A.V. Belonovski, I.V. Levitskii, M.I. Mitrofanov,
E.I. Girshova, K.A. Ivanov, S.N. Rodin, K.M. Morozov,
V.P. Evtikhiev, M.A. Kaliteevski

*Linköping University, Sweden & St.Petersburg Academic University, Russia
& ITMO University & Ioffe Institute, Russia*

Fr-2o 10:15 – 10:30

Photoluminescence and Stimulated Emission of Ultrathin GaN/AlN Quantum Wells”

E.V. Lutsenko, M.V. Rzheutski, A.V. Nahorny, A.V. Danilchyk,
D.V. Nechaev, V.N. Jmerik, S.V. Ivanov
Stepanov Institute of Physics, NASB, Belarus & Ioffe Institute, Russia

Fr-3o	10:30 – 10:45	Achievement of Internal Quantum Efficiency up to 53% at 326nm-UVA Emission from AlGaN QWs with Engineering of Highly Relaxed Buffer Layer <u>M.A. Khan</u> , R. Takeda, H. Miyoshi, Y. Yamada, S. Fujikawa, N. Maeda, M. Jo, and H. Hirayama <i>RIKEN Center for Advanced Photonics, Japan & Yamaguchi University, Japan & Tokyo Denki University, Japan</i>
		<i>Coffee Break</i> 10:45 - 11:15
		Session 11 “Fundamentals of AlGaN nanostructures” 11:15 - 12:40 Session Chair: Debdeep Jena
Fr-4i	11:15 – 11:35	Understanding and Mitigating the Efficiency Challenges of Deep-UV Light Emitters with Atomistic Calculations (<i>invited</i>) <u>Emmanouil Kioupakis</u> <i>University of Michigan, USA</i>
Fr-5i	11:35 – 11:55	Watt’s in AlN/GaN/AlN Quantum Well HEMTs? (<i>invited</i>) <u>Grace Xing</u> <i>Cornell University, USA</i>
Fr-4o	11:55 – 12:10	Currents in Nitride Tunnel Junctions <u>J.-Y. Duboz</u> , V. fan Arcara, and B. Vinter <i>Université Côte d’Azur, France & CRHEA-CNRS, France</i>
Fr-5o	12:10 – 12:25	Engineering the Orbital-State Coupling for the Quantum Confinement in the Valence Band for High Al Content AlGaN <u>W. Lin</u> , L. Chen, Y. Wu, C. Zhang, Zh. Wu, Y. Dong, and J. Kang <i>Fujian Provincial Key Laboratory of Semiconductors and Applications, Department of Physics, Xiamen University, China</i>
Fr-6o	12:25 – 12:40	Numerical Modeling and Experimental Demonstration for Nitride-Based Optoelectronic Devices <u>Z.-H. Zhang</u> and H.-C. Kuo <i>Hebei University of Technology, China</i>
		<i>Lunch</i> 12:40 - 14:00

Plenary and Keynotes Session II

14:00 - 15:45

Session Chair: Sergey Ivanov

Fr-1K 14:00 - 14:30

Development of β -Ga₂O₃ and β -(Al_xGa_{1-x})₂O₃/Ga₂O₃

Heterostructures by Plasma-Assisted MBE (keynote)

Akhil Mauze, James Speck

University of California, Santa Barbara, USA

Fr-2K 14:30 - 15:00

Deep UV Emission in Hexagonal Boron Nitride: from Bulk to Monolayer (keynote)

Guillaume Cassabois

University of Montpellier, CNRS, France

Fr-1P 15:00 – 15:45

The Prospects of AlGaN-Based Deep UV LED Technologies (plenary)

Michael Kneissl

Technische Universität Berlin & Ferdinand-Braun-Institut, Germany

Closing remarks

15:45 - 16:00

POSTER SESSION I

Tuesday, September 10

18:00- 19:30

- Tu-1p **Optical Properties of AlGaN Bulk Films Grown throughout the Composition Range by Plasma Assisted Molecular Beam Epitaxy**
S. Sen, Ch. Singha, A. Saha, P. Pramanik, A. Bhattacharyya
Centre for Research in Nanoscience and Nanotechnology, University of Calcutta, India
- Tu-2p **Stress Evolution During Growth of AlN Templates on c-Al₂O₃ Substrates by Plasma-Ssisted Molecular Beam Epitaxy**
O.A. Koshelev, D.V. Nechaev, V.V. Ratnikov, P.N. Brunkov,
S.V. Ivanov and V.N. Jmerik
Ioffe Institute, Russia
- Tu-3p **Raman Scattering in AlN Crystals Grown on SiC and AlN Substrates by Sublimation Method**
I.D. Breev, A.K. Simonyan, A.N. Anisimov, P.G. Baranov,
E.N. Mokhov
Ioffe Institute, Russia
- Tu-4p **5.6-micron-Thick Crack-Free AlN with Low TDD Grown on Sputtered AlN/Sapphire**
Ch. He, W. Zhao, H. Wu, Sh. Zhang, K. Zhang, L. He, N. Liu,
Zh. Chen, B. Shen
Guangdong Institute of Semiconductor Industrial Technology, Guangdong Academy of Sciences, China & School of Physics & Electronic Engineering, Guangzhou University, China & State Key Laboratory of Artificial Microstructure and Mesoscopic Physics, School of Physics, Peking University, China
- Tu-5p **High-Quality AlN Template on Patterned Sapphire Substrates for Deep Ultra-Violet Light Sources**
S.-J. Lee, S.-R. Jeon, H.-Y. Lee, Y.-J. Choi, S.-G. Hong
Korea Photonics Technology Institute, Korea & LumiGNtech Co., Ltd., Korea & Chungnam National University, South Korea
- Tu-6p **AlN Templates Grown By Ammonia MBE on c-Al₂O₃ Substrates for AlGaN-Based Heterostructures**
E. Lutsenko, M. Rzheutski, A. Vainilovich, I. Svitsiankou,
A. Nahorny, V. Zubialevich, G. Yablonskii, S. Petrov, A. Alexeev
Institute of Physics of the NASB, Belarus & Tyndall National Institute, Ireland & SemiTEq JSC, Russia

- Tu-7p **Crack-Free thick AlN Grown on μ -Cone Patterned Sapphire Substrates with Sputter-Deposited Annealed AlN film by Hydride Vapor-Phase Epitaxy**
Sh. Xiao, K. Shojiki, K. Uesugi, and H. Miyake
Mie University, Grad. School of RIS, Japan & Mie University, Grad. School of Eng., Japan & Mie University, SPORR, Japan
- Tu-8p **High-Speed Homoepitaxial Growth of AlN above 100 $\mu\text{m/h}$ by Hydride Vapor Phase Epitaxy**
N. Takekawa, Y. Shimizu, D. Saito, T. Nagashima, R. Yamamoto, K. Goto, B. Monemar, and Y. Kumagai
Department of Applied Chemistry, Tokyo University of Agriculture and Technology, Japan & Tsukuba Research Laboratories, Tokuyama Corporation, Tsukuba, Japan & Department of Physics, Chemistry and Biology (IFM), Linköping University, Sweden & Institute of Global Innovation Research, Tokyo University of Agriculture and Technology, Japan
- Tu-9p **2-inch Bulk AlN Crystals for DUV LED Application**
E. Mohov, A. Usikov, O. Kazarova, S. Nagalyk, O. Avdeev, G. Fan, L. Zhao, H. Helava, Yu. Makarov
Ioffe Institute, Russia & Nitride Crystals Inc., USA & ITMO University, Russia & Nitride Crystals Group Ltd., Russia & School of Chemistry and Chemical Engineering, Harbin Institute of Technology, China
- Tu-10p **High Quality AlN/Sapphire Templates with High Growth Rates by MOCVD**
H. Wu, C. He, W. Zhao, K. Zhang, L. He, N. Liu, Q. Liao, Y. Liu, and Zh. Chen
Guangdong Institute of Semiconductor Industrial Technology, Guangdong Academy of Sciences, Guangzhou, China
- Tu-11p **Optical Properties of (Al)GaNAs Alloys and Quantum Wells Dedicated for UV Emitters**
R. Kudrawiec, E. Zdanowicz, P. Ciechanowicz, K. Opolczynska, D. Majchrzak, J.-G. Rousset, E. Piskorska-Hommel, M. Grodzicki, K. Komorowska, and D. Hommel
Lukasiewicz Research Network – PORT Polish Center for Technology Development, Poland & Faculty of Fundamental Problems of Technology, Wroclaw University of Science and Technology, Poland & Institute of Experimental Physics, University of Wroclaw, Poland & Institute of Low Temperature and Structure Research PAS, Poland

- Tu-12p **Efficiency Evaluation Method Based on Optical Polarization Properties for AlGaN Deep-UV LEDs**
H. Lu, H. Wang, T. Yu, and J. Wang
School of Computer and Communication Engineering, University of Science and Technology Beijing, China & The State Key Laboratory for Mesoscopic Physics, School of Physics, Peking University, China
- Tu-13p **Growth of Si-doped AlGaN on High-Temperature-Annealed MOVPE-Grown AlN Films on Vicinal Sapphire with Sputtered AlN Seed Layers**
S. Kuboya, Y. Tezen, K. Uesugi, K. Norimatsu, K. Shojiki, and H. Miyake
Mie University, Japan
- Tu-14p **Development of 2-inch and 4-inch AlN Template for UVC LED by High Temperature MOCVD**
B. Lee, S. Hong, H. Shin, T. Lim, and M. Choi
TOP Engineering, Korea
- Tu-15p **Suppressing the Compositional Nonuniformity of AlGaN Grown on a HVPE-AlN Template with Large Macro-Steps**
D. Li, X. Sun, K. Jiang, and J. Ben
State Key Laboratory of Luminescence and Applications, Changchun Institute of Optics, Fine Mechanics and Physics, CAS, China & Center of Materials Science and Optoelectronics Engineering, University of CAS, China
- Tu-16p **Estimation of Radiative and Auger Recombination Constants for (0001)AlGaN Quantum Wells**
S. Yu. Karpov
STR Group - Soft-Impact, Ltd., Russia
- Tu-17p **Impact of Nanoarrangement of Si-Doped AlGaN Layers and GaN/AlN Digital Alloys on the Free Electron Concentrations**
A.N. Semenov, N.M. Shmidt, D.V. Nechaev, O.A. Koshelev, E.V. Gushchina, E.I. Shabunina, M.S. Dunaevsky, I.P. Smirnova, Yu.A. Guseva, D.S. Burenina, V.Yu. Davydov, A.N. Smirnov, S.V. Ivanov, V.N. Jmerik
Ioffe Institute, Russia
- Tu-18p **Growth Kinetics and Stress Evolution in Plasma-Assisted MBE of Monolayer-Thick GaN/AlN MQW Structures and Superlattices**
D.V. Nechaev, O.A. Koshelev, A.N. Semenov, K.N. Orekhova, D.A. Kirilenko, P.N. Brunkov, M.V. Rzheutski, E.V. Lutsenko, S.V. Ivanov, and V.N. Jmerik
Ioffe Institute, Russia & Stepanov Institute of Physics, Belarus

POSTER SESSION II

Wednesday, September 11

18:00- 19:30

- We-1p **Micro-Photoluminescence Imaging of Hexagonal Boron Nitride Crystal in the UV Range**
T. Pelini, A. Dreau, C. Elias, P. Valvin, , G. Cassabois, B. Gil,
V. Jacques, J. Li, J.H. Edgar
CNRS, Laboratoire Charles Coulomb UMR5221, France & Kansas State University, Tim Taylor Department of Chemical Engineering, USA
- We-2p **Effect of Oxygen on the Electrical Resistance of Gallium Oxide Thin Films of Doped With Chromium**
A. Almaev, E. Chernikov, B. Kushnarev
National Research Tomsk State University, Russia
- We-3p **Low Temperature Growth of Tm Doped Gallium Oxide Films by Plasma-Assisted Pulsed Laser Deposition**
Q. Guo, S. Motomura, K. Saito, T. Tanaka
Department of Electrical and Electronic Engineering, Synchrotron Light Application Center, Saga University, Japan
- We-4p **Effect of Substrate Material on Electrical Characteristics of Ga₂O₃ films**
V. Kalygina, T. Lygdenova, Y. Petrova, E. Chernikov
National Research Tomsk State University, Russia
- We-5p **Effects of C Contamination of Ga₂O₃:Si Target on PLD Thin Film Properties**
P. Kirilenko, C.-H. Liao, X. Li, K.-H. Li
King Abdullah University of Science and Technology (KAUST), Advanced Semiconductor Lab, Saudi Arabia
- We-6p **Studies of Ga₂O₃ Nanoparticles for Biocompatible Applications**
G. Pozina, N. Abrikossova, C. Hemmingsson
Linköping University, Sweden
- We-7p **Performance Enhancement of AlGaN-Based DUV LEDs with Selective-Area Grown p-GaN Contact Layer**
Y. Guo, J. Yan, Y. Zhang, J. Li, J. Wang
Institute of Semiconductors, CAS, China & University of CAS, China

- We-8p **Fabrication of High-Voltage Flip Chip Deep Ultraviolet LEDs**
Zh. Zhong, X. Zheng, J. Li, J. Zheng, W. Lin, Y. Zhou, and J. Kang
*Fujian Provincial Key Laboratory of Semiconductors and Applications,
Collaborative Innovation Center for Optoelectronic Semiconductors and
Efficient Devices, Department of Physics, Xiamen University, China*
- We-9p **Investigation of the Quantum Barrier Grading in Deep UV LED**
Y. Lu, J. Yan, J. Li, X. Li
*King Abdullah University of Science & Technology (KAUST), Advanced
Semiconductor Laboratory, Saudi Arabia & Research and Development
Center for Solid-State Lighting, Institute of Semiconductors, CAS, China*
- We-10p **Modulation of Extracted Light Radiation Patterns In AlGaN-Based Deep-Ultraviolet Light-Emitting Diodes**
H. Wang, H.M. Lu, T.J. Yu
*State Key Laboratory for Artificial Microstructures and Mesoscopic Physics,
School of Physics, Peking University, China & School of Computer and
Communication Engineering, University of Science and Technology Beijing,
China*
- We-11p **Deep Ultraviolet Light-Emitting Diodes with Improved Performance via Nanoporous Template**
L. Zhang, J. Yan, Y. Guo, J. Li, and J. Wang
Institute of Semiconductors, CAS, China & University of CAS, China
- We-12p **Performance Improvement of Deep Ultraviolet Light Emitting Diode by Optimization of Electron Block Layer Thickness and Mg Concentration in p-GaN Contact Layer**
A. Mishima, Y. Tomita, Y. Yamaoka, T. Arimura, S. Koseki, Y. Yano, K. Matsumoto, H. Hirayama
*TNCSE, Tsukuba, Japan & Taiyo Nippon Sanso Corporation, Tsukuba;
RIKEN, Japan*
- We-13p **Wavelength Selective UV Photodetectors Based on Lateral Transport in GaN/AlGaN, AlGaN/AlGaN and AlGaN/AlN MQWs**
P. Pramanik, S. Sen, C. Singha, A. Bhattacharyya
*Institute of Radio Physics and Electronics, University of Calcutta, India &
Centre for Research in Nanoscience and Nanotechnology, University of
Calcutta, India*
- We-14p **Design and Fabrication of High-performance 1-D Photonic Crystal UV Filter for Back-Illuminated AlGaN Solar-blind Photodetector**
H. You, R. Yuan, D. Pan, Q. Cai, D. Chen, R. Zhang, Y. Zheng
*Key Laboratory of Advanced Photonic and Electronic Materials, School of
Electronic Science and Engineering, Nanjing University, China*

- We-15p **A Multiband Electron-Beam Pumped Deep Ultraviolet Light Source Based on Ultrathin GaN/AlN MQWs**
Y.X. Wang, S.V. Ivanov, T. Wang, B. Sheng, S. Guo, V.I. Kozlovsky, F. Bertram, H. Li, X. Rong, Z.X. Qin, J. Christen, B. Shen and X.Q. Wang
State Key Laboratory of Artificial Microstructure and Mesoscopic Physics, School of Physics, Peking University, China & Ioffe Institute, Russia & Advanced Micro-Fabrication Equipment Inc., China & Lebedev Physical Institute, RAS, Russia
- We-16p **Analysis of the Degradation Behaviour of 310 nm UVB LEDs by Temperature-Dependent Electroluminescence Spectroscopy**
P. Gupta, J. Höpfner, M. Guttmann, J. Ruschel, J. Glaab, T. Kolbe, A. Knauer, T. Wernicke, M. Weyers, M. Kneissl
Technical University of Berlin, Institute of Solid State Physics, Germany & Ferdinand-Braun-Institute, Leibniz Institute for High Frequency Technology, Germany
- We-17p **Simultaneous Emission-Detection Operation of Subwavelength Vertical-Structure LED**
L. Wang, Y. Jiang, K. Fu, X. Gao, X. Xu, J. Yuan, and Y. Wang
Nanjing University of Posts and Telecommunications, China
- We-18p **Threshold Reduced and Directional Single Mode Emission of Near UV Bend-up Microring Cavity**
Y. Li, S. Zhang, M. Guo, Y. Zhang, F. Yun, X. Hou
Xi'an Jiaotong University, China